Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/808,776	AHN ET AL.	
Examiner	Art Unit	
Nam Huynh	2643	

SEARCHED					
Class	Subclass	Date	Examiner		
455	575.1	12/20/2005	NTH		
	575.4				
	575.8				
379	428.04	12/20/2005	NTH		
	433.11-12				
	440				
	437				
	445				
292	121	12/20/2005	NTH		
	163				
	150				
	145				
	175				
	302				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
See EAST search notes.	12/20/2005	NTH		